

Notice of References Cited	Application/Control No. 10/578,572		Applicant(s)/Patent Under Reexamination DEROO ET AL.	
	Examiner Victor Kostak		Art Unit 2622	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,167,352 A	12-2000	Kanevsky et al.	702/81
*	B	US-7,304,482 B1	12-2007	Kay et al.	324/615
*	C	US-2002/0047828 A1	04-2002	Stern et al.	345/156
*	D	US-7,233,312 B2	06-2007	Stern et al.	345/156
*	E	US-2006/0033880 A1	02-2006	Korneluk, Jose Eduardo	351/242
*	F	US-5,483,259 A	01-1996	Sachs, Jonathan M.	345/600
*	G	US-2002/0130975 A1	09-2002	Yang et al.	348/674
*	H	US-2005/0225639 A1	10-2005	Somers, Steve	348/181
*	I	US-7,538,791 B2	05-2009	Sugiyama et al.	348/189
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
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	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
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	X				

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